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| <b>Notice of References Cited</b> | Application/Control No.<br>09/764,064 | Applicant(s)/Patent Under<br>Reexamination<br>OH ET AL. |             |
|                                   | Examiner<br>Behrooz Senfi             | Art Unit<br>2613  | Page 1 of 1 |

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|   | A | US-6,363,061                                     | 03-1998         | Yuzawa 03/2002     | 370/498        |
|   | B | US-6,594,798                                     | 05-1999         | Chou et al 07/2003 | 714/822        |
|   | C | US-6,125,201                                     | 06-1997         | Zador 09/2000      | 382/248        |
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|   | F | US-5,539,823                                     | 07-1994         | Martin 07/1996     | 380/226        |
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